Searcn Notes				

Application No.	Applicant(s)	_
10/076,374	VAN DER SCHAAR, MIHA	AELA
Examiner	Art Unit	
Motthour Honov	2612	

SEARCHED				
Class	Subclass	Date	Examiner	
375	240.01	10/7/2004	MJH	
375	240.20			
375 375	240,26	V	V	
		`		
			*	
		,		
			*	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		, , , , ,	

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
See Attached Search History Notes	10/7/2004	МЈН
IEEE search: bitplane <and> zig zag, block <and> dct, fgs <and> block, most <and> significant <and> dct</and></and></and></and></and>	10/6/2004	MJH
IEEE search: granular <and> scalability, (bitplane <or> bit plane) <and> zigzag</and></or></and>	10/7/2004	MJH
ACM Digital Library: scalability granular bitplane, bitplane zigzag	10/7/2004	MJH